

## Is Now Part of



# ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at <a href="https://www.onsemi.com">www.onsemi.com</a>

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, emplo



November 2013

# **FDP3672**

# N-Channel PowerTrench<sup>®</sup> MOSFET 105 V, 41 A, 33 m $\Omega$

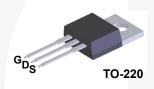
### **Features**

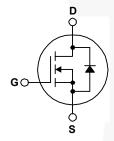
- $R_{DS(on)}$  = 25 m $\Omega$  ( Typ.) @  $V_{GS}$  = 10 V,  $I_D$  = 41 A
- $Q_{G(tot)}$  = 28 nC ( Typ.) @  $V_{GS}$  = 10 V
- Low Miller Charge
- Low Q<sub>rr</sub> Body Diode
- Optimized Efficiency at High Frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)

# **Applications**

- Consumer Appliances
- · Synchronous Rectification
- · Battery Protection Circuit
- · Motor drives and Uninterruptible Power Supplies
- · Micro Solar Inverter

Formerly developmental type 82760





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

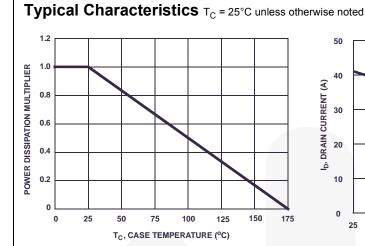
Symbol	Parameter	FDP3672	Unit
$V_{DSS}$	Drain to Source Voltage	105	V
V <sub>GS</sub>	Gate to Source Voltage	±20	V
	Drain Current		
I <sub>D</sub>	Continuous ( $T_C = 25^{\circ}C$ , $V_{GS} = 10V$ )	41	Α
	Continuous (T <sub>C</sub> = 100°C, V <sub>GS</sub> = 10V)	31	А
	Continuous ( $T_{amb} = 25^{\circ}C$ , $V_{GS} = 10V$ , $R_{\theta JA} = 62^{\circ}C/W$ )	5.9	А
	Pulsed	Figure 4	Α
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 1)	48	mJ
P <sub>D</sub>	Power dissipation	135	W
	Derate above 25°C	0.9	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-55 to 175	°C

# **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	1.11	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max. (Note 2)	62	°C/W

Device Marking FDP3672		Device	Package	Re	eel Size	Tape \	Width	Qua	ntity
		FDP3672	TO-220 Tube		Tube	N/A		50 units	
Electric	al Chara	acteristics T <sub>C</sub> = 25°C	unless otherwis	se not	ed				
Symbol		Parameter Test Conditions			Min	Тур	Max	Unit	
Off Chara	cteristics	•	•		•		•	•	•
B <sub>VDSS</sub>	Drain to So	ource Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		105	-	-	V	
_	Zero Gate Voltage Drain Current		V <sub>DS</sub> = 80V		-	-	1		
I <sub>DSS</sub>			$V_{GS} = 0V$			-	-	250	μΑ
I <sub>GSS</sub>			$V_{GS} = \pm 20V$			-	-	±100	nA
On Chara	cteristics						•	•	
V <sub>GS(TH)</sub>	Gate to Source Threshold Voltage		$V_{GS} = V_{DS}$	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		2	-	4	V
00(111)			_	$_{D} = 41A, V_{GS} = 10V$		-	0.025	0.033	
r	Drain to So	ource On Resistance	$I_D = 21A, V$	$I_D = 21A, V_{GS} = 6V,$		-	0.031	0.055	Ω
r <sub>DS(ON)</sub> Drain to S		Juice Off Resistance	I <sub>D</sub> = 41A, V <sub>GS</sub> = 10V, T <sub>C</sub> = 175°C		-	0.063	0.070	122	
Dynamic	Characte	ristics							
C <sub>ISS</sub>	Input Capa	acitance				-	1670	-	pF
C <sub>OSS</sub>	Output Ca	pacitance	V <sub>DS</sub> = 25V, f = 1MHz	$V_{DS} = 25V, V_{GS} = 0V,$		- \	240	-	pF
C <sub>RSS</sub>	Reverse Ti	ransfer Capacitance	1 = 1101112			- \	55	-	pF
Q <sub>g(TOT)</sub>	Total Gate	Charge at 10V	$V_{GS} = 0V to$	10V		-	28	37	nC
$Q_{g(TH)}$	Threshold	Gate Charge	$V_{GS} = 0V to$	2V	V <sub>DD</sub> = 50V	-	3.9	5	nC
Q <sub>gs</sub>	Gate to Sc	ource Gate Charge		$I_D = 41A$ $I_g = 1.0 \text{mA}$		-	12	-	nC
Q <sub>gs2</sub>	Gate Char	ge Threshold to Plateau				-	8.0	-	nC
Q <sub>gd</sub>	Gate to Dr	ain "Miller" Charge				-	6.5	-	nC
	Switchin	g Characteristics (V	<sub>3S</sub> = 10V)						
t <sub>ON</sub>	Turn-On T	ime				- /	-	90	ns
t <sub>d(ON)</sub>	Turn-On D	elay Time				-/	12	-	ns
t <sub>r</sub>	Rise Time		$V_{DD} = 50V, I_{D} = 41A$ $V_{GS} = 10V, R_{GS} = 11.0\Omega$		/-	48	-	ns	
t <sub>d(OFF)</sub>	Turn-Off D	elay Time			-	24	-/	ns	
t <sub>f</sub>	Fall Time				-	27	/-	ns	
t <sub>OFF</sub>	Turn-Off T	ime				-	-	77	ns
Drain-Sou	urce Diod	e Characteristics	-						
	Source to Drain Diode Voltage		I <sub>SD</sub> = 41A			-	-	1.25	V
$V_{SD}$			I <sub>SD</sub> = 21A			-	-	1.0	V
t <sub>rr</sub>	Reverse R	ecovery Time	I <sub>SD</sub> = 41A,	dl <sub>SD</sub> /d	t =100A/μs	-	-	39	ns
Q <sub>RR</sub>	Reverse R	ecovered Charge	$I_{SD} = 41A$ , $dI_{SD}/dt = 100A/\mu s$			-	-	42	nC

Notes: 1: Starting  $T_J = 25^{\circ}C$ , L = 0.11mH,  $I_{AS} = 30$ A. 2: Pulse Width = 100s



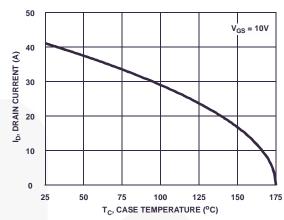


Figure 1. Normalized Power Dissipation vs Ambient Temperature

Figure 2. Maximum Continuous Drain Current vs Case Temperature

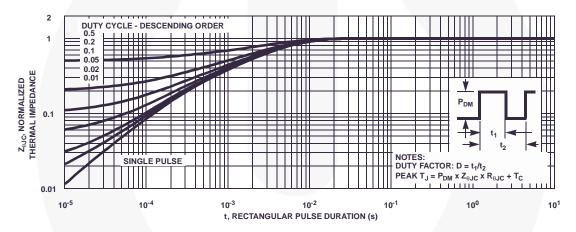


Figure 3. Normalized Maximum Transient Thermal Impedance

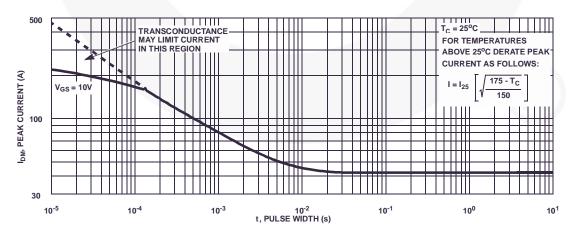
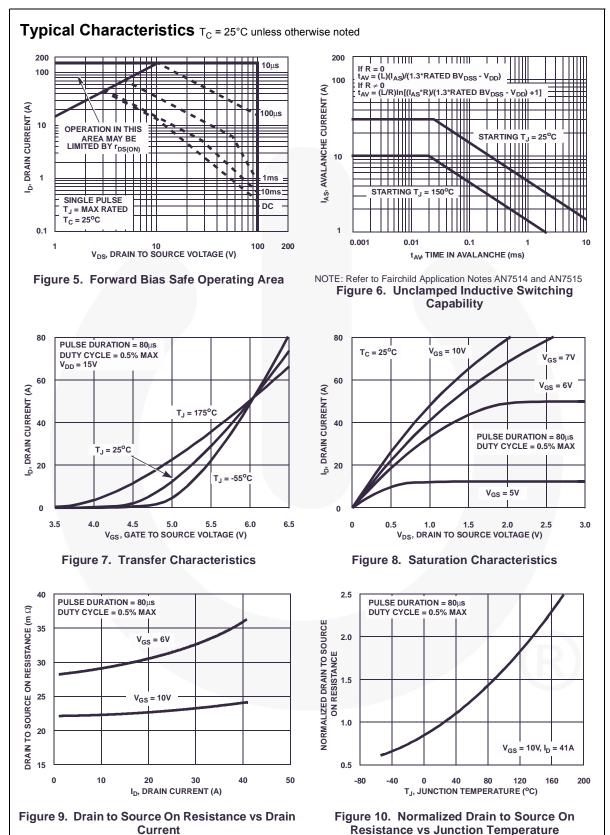


Figure 4. Peak Current Capability



# Typical Characteristics T<sub>C</sub> = 25°C unless otherwise noted

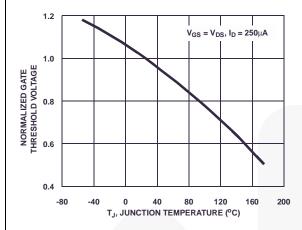


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

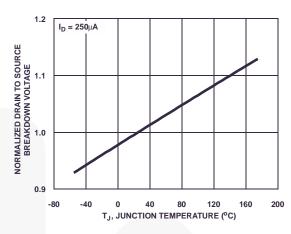


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

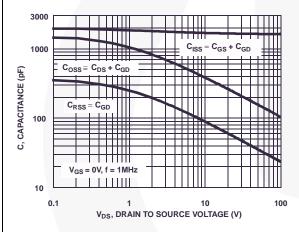


Figure 13. Capacitance vs Drain to Source Voltage

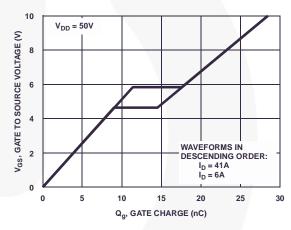


Figure 14. Gate Charge Waveforms for Constant Gate Currents

# **Test Circuits and Waveforms**

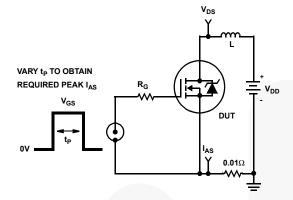


Figure 15. Unclamped Energy Test Circuit

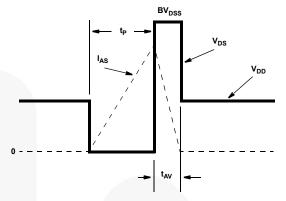


Figure 16. Unclamped Energy Waveforms

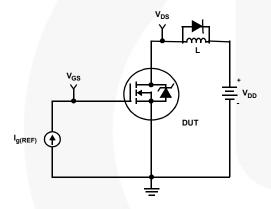


Figure 17. Gate Charge Test Circuit

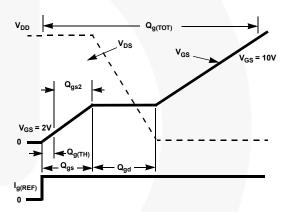


Figure 18. Gate Charge Waveforms

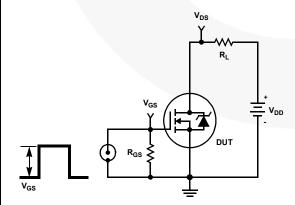


Figure 19. Switching Time Test Circuit

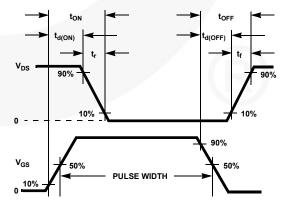
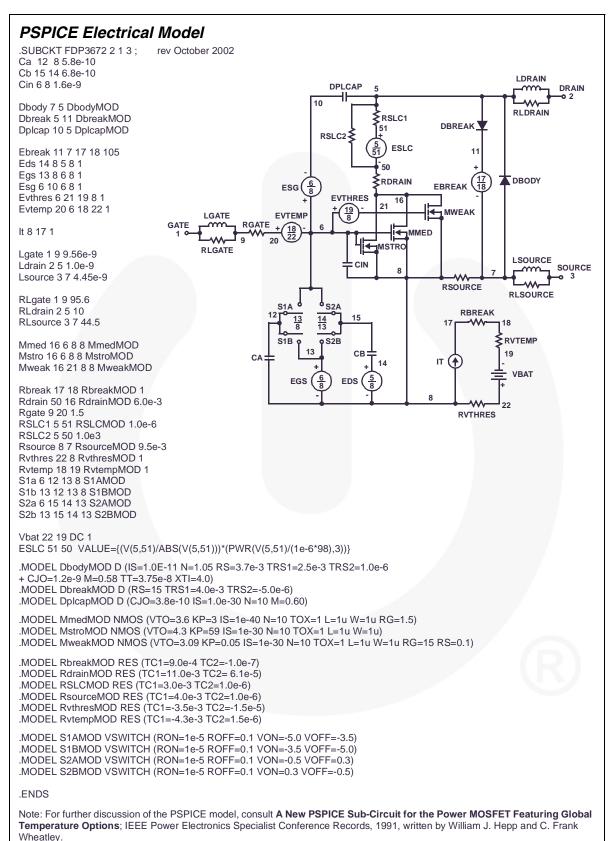


Figure 20. Switching Time Waveforms



#### SABER Electrical Model REV October 2002 template FDP3672 n2,n1,n3 electrical n2,n1,n3 var i iscl dp..model dbodymod = (isl=1.0e-11,nl=1.05,rs=3.7e-3,trs1=2.5e-3,trs2=1.0e-6,cjo=1.2e-9,m=0.58,tt=3.75e-8,xti=4.0) dp..model dbreakmod = (rs=15,trs1=4.0e-3,trs2=-5.0e-6) dp..model dplcapmod = (cjo=3.8e-10,isl=10.0e-30,nl=10,m=0.60) m..model mmedmod = $(type=_n, vto=3.6, kp=3, is=1e-40, tox=1)$ m..model mstrongmod = (type=\_n,vto=4.3,kp=59,is=1e-30, tox=1) m..model mweakmod = $(type=_n, vto=3.09, kp=0.05, is=1e-30, tox=1, rs=0.1)$ sw\_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-5.0,voff=-3.5) LDBAIN sw\_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-3.5,voff=-5.0) DPLCAP DRAIN sw\_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-0.5,voff=0.3) 10 sw\_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=0.3,voff=-0.5) RLDRAIN ₹RSLC1 c.ca n12 n8 = 5.8e-1051 c.cb n15 n14 = 6.8e-10RSLC2 c.cin n6 n8 = 1.6e-9ISCL DBREAK \_ dp.dbody n7 n5 = model=dbodymod 50 dp.dbreak n5 n11 = model=dbreakmod RDRAIN <u>6</u> dp.dplcap n10 n5 = model=dplcapmod ESG ( DRODY **EVTHRES** spe.ebreak n11 n7 n17 n18 = 105 19 MWFAK **LGATE EVTEMP** spe.eds n14 n8 n5 n8 = 1 GATE 18 22 MMED **EBREAK** spe.egs n13 n8 n6 n8 = 1 Ιg 20 spe.esg n6 n10 n6 n8 = 1 MSTRO RLGATE spe.evthres n6 n21 n19 n8 = 1LSOURCE CIN SOURCE spe.evtemp n20 n6 n18 n22 = 1 RSOURCE i.it n8 n17 = 1RLSOURCE I.lgate n1 n9 = 95.6e-9 RBREAK I.Idrain n2 n5 = 1.0e-9I.lsource n3 n7 = 4.45e-9**₹**RVTEMP o S2B 19 res.rlgate n1 n9 = 9.56 IT res.rldrain n2 n5 = 10 VBAT res.rlsource n3 n7 = 44.5 EGS m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u **RVTHRES** m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u res.rbreak n17 n18 = 1, tc1=9.0e-4,tc2=-1.0e-7 res.rdrain n50 n16 = 6.0e-3, tc1=11.0e-3,tc2=6.1e-5 res.rgate n9 n20 = 1.5 res.rslc1 n5 n51 = 1.0e-6, tc1=3.0e-3,tc2=1.0e-6 res.rslc2 n5 n50 = 1.0e3res.rsource n8 n7 = 9.5e-3, tc1=4.0e-3,tc2=1.0e-6 res.rvthres n22 n8 = 1, tc1=-3.5e-3,tc2=-1.5e-5 res.rvtemp n18 n19 = 1, tc1=-4.3e-3,tc2=1.5e-6 sw\_vcsp.s1a n6 n12 n13 n8 = model=s1amod sw\_vcsp.s1b n13 n12 n13 n8 = model=s1bmod sw\_vcsp.s2a n6 n15 n14 n13 = model=s2amod sw\_vcsp.s2b n13 n15 n14 n13 = model=s2bmod v.vbat n22 n19 = dc=1 equations { i (n51->n50) +=iscl iscl: v(n51,n50) = ((v(n5,n51)/(1e-9+abs(v(n5,n51))))\*((abs(v(n5,n51)\*1e6/98))\*\*3))

# SPICE Thermal Model JUNCTION th REV October 2002 FDP3672 CTHERM1 TH 6 3.2e-3 CTHERM2 6 5 3.3e-3 CTHERM3 5 4 3.4e-3 RTHERM1 CTHERM1 CTHERM4 4 3 3.5e-3 CTHERM5 3 2 6.4e-3 CTHERM6 2 TL 1.9e-2 6 RTHERM1 TH 6 5.5e-4 RTHERM2 6 5 5.0e-3 RTHERM3 5 4 4.5e-2 RTHERM2 CTHERM2 RTHERM4 4 3 10.5e-2 RTHERM5 3 2 3.4e-1 RTHERM6 2 TL 3.5e-1 SABER Thermal Model SABER thermal model FDP3672 RTHERM3 CTHERM3 template thermal\_model th tl thermal\_c th, tl cctherm.ctherm1 th 6 =3.2e-3 ctherm.ctherm2 6 5 = 3.3e-3ctherm.ctherm3 5 4 = 3.4e-3 ctherm.ctherm4 4 3 = 3.5e-3 ctherm.ctherm5 3 2 =6.4e-3 RTHERM4 CTHERM4 ctherm.ctherm6 2 tl =1.9e-2 rtherm.rtherm1 th 6 =5.5e-4 rtherm.rtherm2 6 5 =5.0e-3 3 rtherm.rtherm3 5 4 =4.5e-2 rtherm.rtherm4 4 3 =10.5e-2 rtherm.rtherm5 3 2 = 3.4e-1 RTHFRM5 CTHERM5 rtherm.rtherm6 2 tl =3.5e-1 RTHERM6 CTHERM6 CASE

# **Mechanical Dimensions**

# TO-220 3L

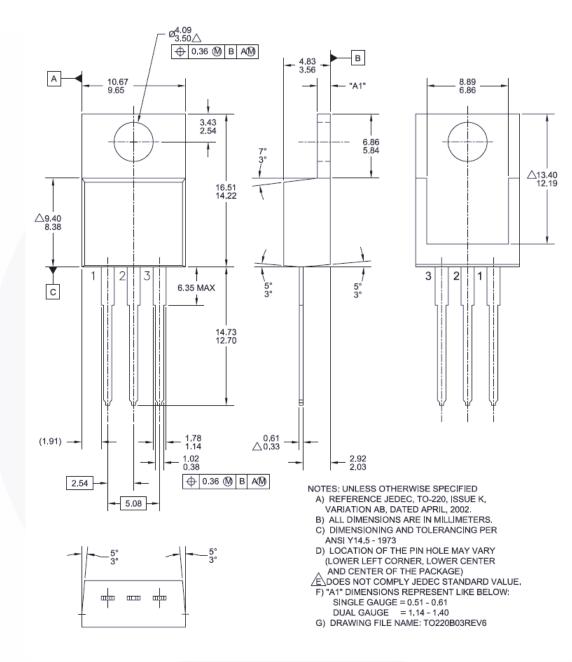


Figure 21. TO-220, Molded, 3Lead, Jedec Variation AB

Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings:

http://www.fairchildsemi.com/package/packageDetails.html?id=PN\_TT220-003

Dimension in Millimeters





#### **TRADEMARKS**

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

AccuPower™ AX-CAP® BitSiC™ Build it Now™ CorePLUS™ CorePOWER™  $CROSSVOLT^{\text{TM}}$ 

CTI ™ Current Transfer Logic™ DEUXPEED® Dual Cool™ EcoSPARK® EfficentMax™

Fairchild<sup>®</sup> Fairchild Semiconductor®

ESBC™

FACT Quiet Series™ FACT® FAST® FastvCore™ FETBench™ FPS™

F-PFS™ FRFET® Global Power Resource<sup>SM</sup>

GreenBridge™ Green FPS™

Green FPS™ e-Series™

G*max*™ GTO™ IntelliMAX™ ISOPLANAR™

Marking Small Speakers Sound Louder

and Better™ MegaBuck™ MICROCOUPLER™ MicroFET™ MicroPak™ MicroPak2™

MillerDrive™ MotionMax™ mWSaver® OptoHiT™ OPTOLOGIC® OPTOPLANAR® PowerTrench® PowerXS™

Programmable Active Droop™ **QFET** 

QS™ Quiet Series™ RapidConfigure™

Saving our world, 1mW/W/kW at a time™ SignalWise™

SmartMax™ SMART START™

Solutions for Your Success™

STEALTH™ SuperFET® SuperSOT™-3

SuperSOT™-6 SuperSOT™-8 SupreMOS® SvncFET™

SYSTEM ®\* TinyBoost<sup>®</sup> TinyBuck<sup>®</sup> TinyCalc™ TinyLogic<sup>®</sup> TINYOPTO™ TinvPower™ TinyPWM™ TinyWire™

Sync-Lock™

TranSiC™ TriFault Detect™ TRUECURRENT®\* μSerDes™

UHC<sup>®</sup> Ultra FRFET™ UniFFT™ VCX™ VisualMax™ VoltagePlus™ XS™

\*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY
FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE
EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 166

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and h

## **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative